CE EMC
TEST REPORT

for

Product: Solar charge controller
Model: DCK4860, DKTD1205, DKTD1210, DKTD1220, DKTD1230, DCK1210, DCK1220, DCK1230, DCK1240, DCK1250, DCK1260, DCK4820, DCK4830, DCK4840, DCK4850
Report No.: KEYS240719034003EM-02

Issued for

SUNFLX NEW ENERGY CO.,LTD
307-08, 3rd Floor, No. 15 Xinning 1st Lane, Nanhua Community Shunde District,Foshan City , Guangdong

Issued by

Guangdong KEYS Testing Technology Co., Ltd.
Address: Building 1, No.18, Shihuan Road, Dongcheng Subdistrict, Dongguan, Guangdong, China
104, No.4, Fumin Street, Shilong, Dongguan, Guangdong, China

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1. TEST CERTIFICATION

Product:	Solar charge controller
Trade Name:	SUNFLX
Model:	DCK4860, DKTD1205, DKTD1210, DKTD1220, DKTD1230, DCK1210, DCK1220, DCK1230, DCK1240, DCK1250, DCK1260, DCK4820, DCK4830, DCK4840, DCK4850
Applicant :	SUNFLX NEW ENERGY CO.,LTD
Address:	307-08, 3rd Floor, No. 15 Xinning 1st Lane, Nanhua Community Shunde District,Foshan City , Guangdong
Manufacturer:	SUNFLX NEW ENERGY CO.,LTD
Address:	307-08, 3rd Floor, No. 15 Xinning 1st Lane, Nanhua Community Shunde District,Foshan City , Guangdong
Test Date:	November 01, 2023 to November 05, 2023
Issued Date:	November 05, 2023
Test Voltage:	Input: DC 48V, 60A USB Output: DC 5V 1A Output: DC 48 V, 60A Max
Applicable Standards:	EN 55032:2015+A1:2020 +A11:2020 EN 55035:2017+A11:2020 EN IEC 61000-3-2:2019/A1:2021 EN 61000-3-3:2013+A1:2019+A2:2021

The above equipment has been tested by Guangdong KEYS Testing Technology Co., Ltd. and found compliance with the requirements in the technical standards mentioned above. The test results presented in this report only relate to the product/system tested. The Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Test Engineer:

Eira Xu / Engineer

Technical Manager:

Summer Xia /Manager

2. TEST SUMMARY

EMISSION			
Standard	**Item**	**Result**	**Remarks**
EN 55032:2015+A1:2020 +A11:2020	Conducted emission (Mains Port)	N/A	N/A
	Radiated emission	PASS	Meet Class B limit
EN IEC 61000-3-2:2019+A1:2021	Harmonic current emissions	N/A	N/A
EN 61000-3-3:2013+A1:2019+A2: 2021	Voltage fluctuations & flicker	N/A	N/A

IMMUNITY			
Standard	**Item**	**Result**	**Remarks**
EN 61000-4-2:2009	ESD	PASS	Complied with the requirements
EN IEC 61000-4-3:2020	RS	PASS	Complied with the requirements
EN 61000-4-4:2012	EFT	N/A	N/A
EN 61000-4-5:2014 +A1:2017	Surge	N/A	N/A
EN 61000-4-6:2023	CS	N/A	N/A
EN 61000-4-8:2010	PFMF	N/A	N/A
EN IEC 61000-4-11:2020	Voltage dips & voltage variations	N/A	N/A

Note: 1) The test result verdict is decided by the limit of test standard.

2) The information of measurement uncertainty is available upon the customer's request.

3. TEST SITE

3.1. TEST FACILITY

Guangdong KEYS Testing Technology Co., Ltd.

Address: Building 1, No.18, Shihuan Road, Dongcheng Subdistrict, Dongguan, Guangdong, China
104, No.4, Fumin Street, Shilong, Dongguan, Guangdong, China

3.2. MEASUREMENT UNCERTAINTY

Parameter	Uncertainty
Temperature	±1° C
Humidity	±5%
DC and Low Frequency Voltages	±3%
Conducted Emission(150KHz-30MHz)	±3.60dB
Radiated Emission(30MHz-1GHz)	±4.76dB
Radiated Emission (1GHz-18GHz)	±4.44dB

Note 1: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.3. LIST OF TEST AND MEASUREMENT INSTRUMENTS

3.3.1. For conducted emission at the mains terminals test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI7	KEYS-E-005	July 1, 2025
Pulse limiter	Rohde&Schwarz	ESH3-Z2	KEYS-E-003	July 1, 2025
LISN impedance network TWO-LINE V-WORK	Rohde&Schwarz	ENV216	KEYS-E-004	July 1, 2025
Screened room	AUDIX	6*3*3	KEYS-E-001	July 23, 2025

3.3.2. For radiated emission test (30MHz-1GHz)

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI7	KEYS-E-005	July 1, 2025
Composite antenna	Schwarzbeck	VULB9168	KEYS-E-013	July 9,2025
Preamplifier	AUDIX	ESH3-Z2	KEYS-E-014	July 1,2025
3m standard semi-anechoic chamber	AUDIX	9*6*6	KEYS-E-002	July 23, 2025

3.3.3. For radiated emission test (1GHz above)

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI7	KEYS-E-005	July 1, 2025
Multiple aerial	Schwarzbeck	9120D	KEYS-E-012	July 9, 2025
Preamplifier	AUDIX	EM01G18G	KEYS-E-015	July 1, 2025
3m standard semi-anechoic chamber	AUDIX	9*6*6	KEYS-E-002	July 23, 2025

3.3.4. For harmonic current emissions and voltage fluctuations/flicker test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Harmonics / Flicker Test System	DCUU INSTRUMENT CO., LTD.	KDF-11005G	KEYS-E-017	July 1,2025
AC Power Source	DCUU INSTRUMENT CO., LTD.	BADT002-11	KEYS-E-025	Aug. 23,2024

3.3.5. For electrostatic discharge immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
ESD Generator	Shanghai Lingshi Electronics Co., LTD	ESD-203A	KEYS-E-023	July 2, 2025

3.3.6. For radio frequency electromagnetic field immunity (R/S) test (DQT)

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Signal Generator	Agilent	N517113-50B	KEYS-EE-038	Sep. 17, 2024
Amplifier	A&R	150W1000M3	KEYS-EE-039	Sep. 17, 2024
Amplifier	A&R	50SIG6M2	KEYS-EE-040	Sep. 17, 2024
Antenna	SCHWARZBECK	STLP9149	KEYS-EE-046	Sep. 17, 2024
Isotropic Field Probe	A&R	FL7006	KEYS-EE-049	Sep. 17, 2024
Log-periodic Antenna	SCHWARZBECK	STLP 9128E	KEYS-EE-042	Sep. 17, 2024

3.3.7. For electrical fast transient/burst immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EFT Tester	HTEC	HEFT 51	KEYS-EE-051	Sep. 17, 2024
EFT Coupling Clamp	HTEC	HEFT 51-C	KEYS-EE-053	Sep. 17, 2024

3.3.8. For surge immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Lightning surge generator	Shanghai Prima Electronics Co., LTD	SUG61005TB-2216	KEYS-E-030	July 2, 2025

3.3.9. For injected currents susceptibility test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
C/S Test System	SCHLODER	CDG-6000-25	KEYS-EE-056	Sep. 17, 2024
Coupling Decoupling Network	SCHLODER	CDN-M2+3	KEYS-EE-059	Sep. 17, 2024
Electromagnetic Injection Clamp	Luthi	EM101	KEYS-EE-066	Sep. 17, 2024

3.3.10. For power frequency magnetic field immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Magnetic Field Tester	HTEC	HPFMF	KEYS-EE-067	Sep. 17, 2024

3.3.11. For voltage dips and short interruptions immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Dips Tester	HTEC	HPFS	KEYS-EE-078	Sep. 17, 2024

4. EUT DESCRIPTION

Product	Solar charge controller
Model	DCK4860
Supplied Voltage	DC 48 V, 60A, Max
Power	--

I/O PORT

I/O PORT TYPES	Q'TY	TESTED WITH
AC Port	1	☐
DC Port	1	☒

Models Difference

All series models are identical, except for model name difference for trading purpose.

Note:
The report is based on previous report with no.: KEYS231105201001EM-02 dated on November 05, 2023 issued by KEYS lab to do below amendment. Others do not any change and not need to do any testing.
-Change application information from "Chengdu DOD New Energy Technology Co., Ltd/ No. 51 (204-19), Tianxiang Road Back Street, Tianxiang Road Community, Wanchun Town, Wenjiang District, Chengdu City , Sichuan ." to "SUNFLX NEW ENERGY CO.,LTD./ No. 51 (204-19), Tianxiang Road Back Street, Tianxiang Road Community, Wanchun Town, Wenjiang District, Chengdu City , Sichuan ."

5. TEST METHODOLOGY

5.1. TEST MODE

The EUT was tested together with the thereinafter additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

The following test mode(s) were assessed.

Test Items		Test Mode
Emission	Conducted Emission	N/A
	Radiated Emission	Working
	Harmonic current emissions	N/A
	Voltage fluctuations & flicker	N/A
Immunity	ESD	Working
	RS	Working
	EFT	N/A
	Surge	N/A
	C/S	N/A
	M/S	N/A
	Dips	N/A

5.2. EUT SYSTEM OPERATION

1. Set up EUT with the support equipment.
2. Make sure the EUT work normally during the test.

6. SETUP OF EQUIPMENT UNDER TEST

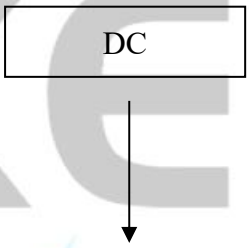
6.1. DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

No.	Equipment	Model	Serial No.	FCC ID	Trade Name	Data Cable	Power Cord
1.	N/A	N/A	N/A	N/A	N/A	N/A	N/A

Note: 1) All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
2) Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

6.2. CONFIGURATION OF SYSTEM UNDER TEST



(EUT: Solar charge controller)

7. EMISSION TEST

7.1. CONDUCTED EMISSION MEASUREMENT

7.1.1. LIMITS

FREQUENCY (MHz)	Class A		Class B	
	Quasi-peak dB(V)	Average dB(V)	Quasi-peak dB(V)	Average dB(V)
0.15 - 0.5	79	66	66-56	56-46
0.5 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

Note: 1) The lower limit shall apply at the transition frequencies.
2) The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50 MHz.

7.1.2. TEST PROCEDURES

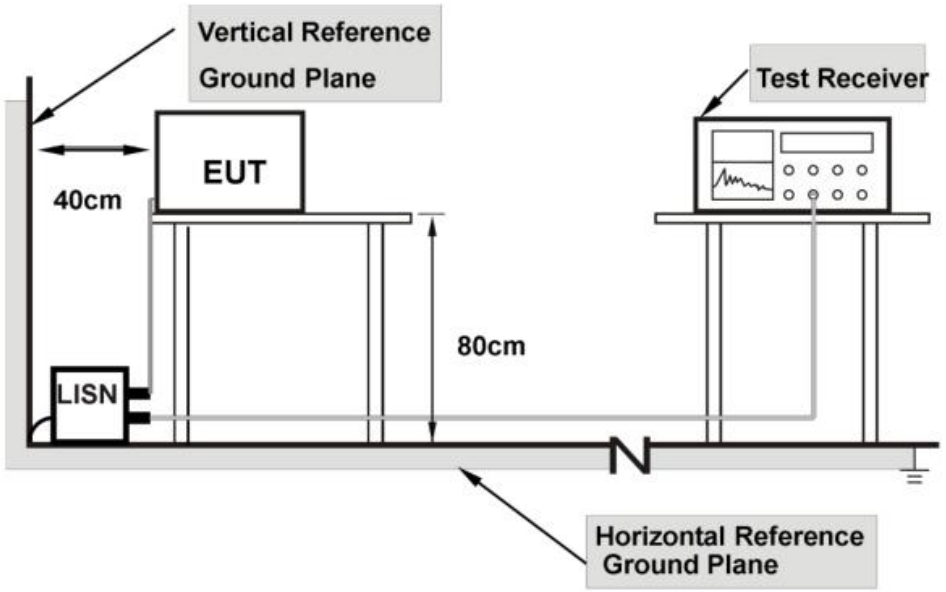
The EUT and Support equipment, if needed, was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane. When the EUT is floor standing equipment, it is placed on the ground plane, which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane. The EUT should be 0.8 m apart from the AMN, where the mains cable supplied by the manufacturer is longer than 1 m, the excess should be folded at the centre into a bundle no longer than 0.4 m, Details please refer to test setup photography.

The Receiver scanned from 150 kHz to 30 MHz for emissions in each of the test modes.
During the above scans, the emissions were maximized by cable manipulation.

A scan was taken on both of the power lines, Line and neutral, recording at least the six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. The test data of the worst-case condition(s) was recorded.

Note: Test Software Name: e3, Software Version: 1.0.0.0.

7.1.3. TEST SETUP



Note: 1.Support units were connected to second LISN.

2.Both of LISNs(AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

7.1.4. TEST RESULT

N/A

7.2. RADIATED EMISSION MEASUREMENT

7.2.1. LIMITS

FREQUENCY (MHz)	Class A(At 3m)	Class B(At 3m)
	Quasi-peak dB(V/m)	Quasi-peak dB(V/m)
30 ~ 230	50	40
230 ~ 1000	57	47

Note: 1) The lower limit shall apply at the transition frequencies.

2) Emission level (dB V/m) = 20 log Emission level (V/m).

7.2.2. TEST PROCEDURE

The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is floor standing equipment, it is placed on the ground plane which has a 0.1 m non-conductive covering to insulate the EUT from the ground plane.

The antenna was placed at 3 meter away from the EUT. The antenna connected to the spectrum analyzer via a cable and at times a pre-amplifier would be used.

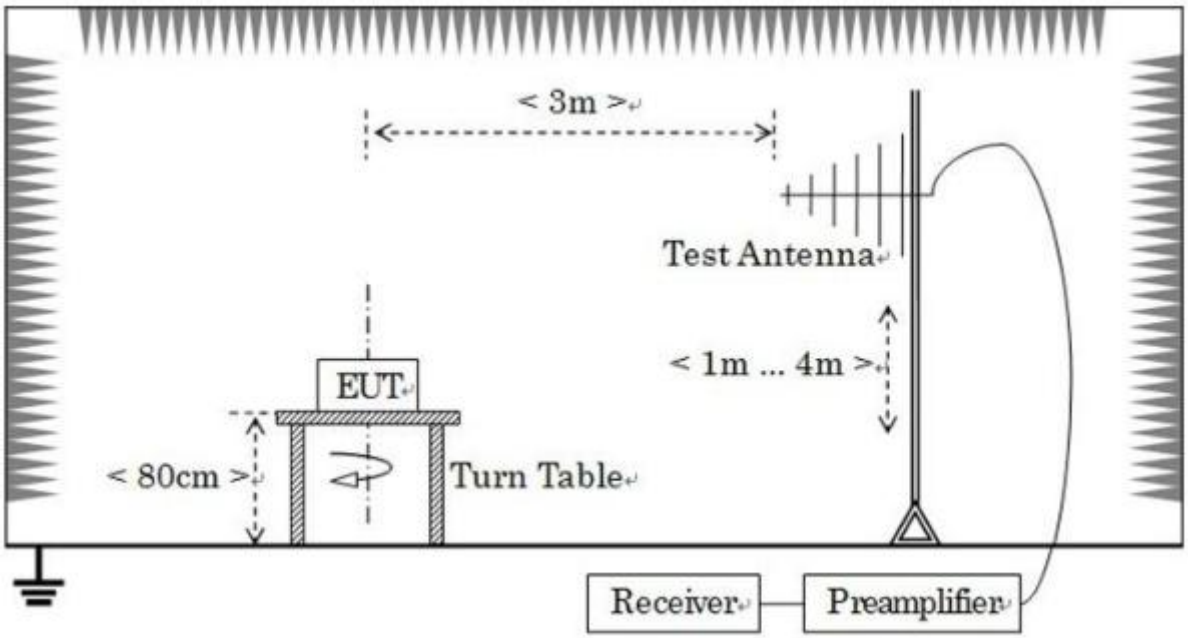
The analyzer / receiver quickly scanned from 30 MHz to 1000 MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

During the above scans, the emissions were maximized by cable manipulation. Each modes is measured, recorded at least the six highest emissions. The emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.

The test data of the worst-case condition(s) was recorded.

Note: Test Software Name: e3, Software Version: 8.2.1.0.

7.2.3. TEST SETUP



Note: For the actual test configuration, please refer to the related item – Photographs of the Test Configuration

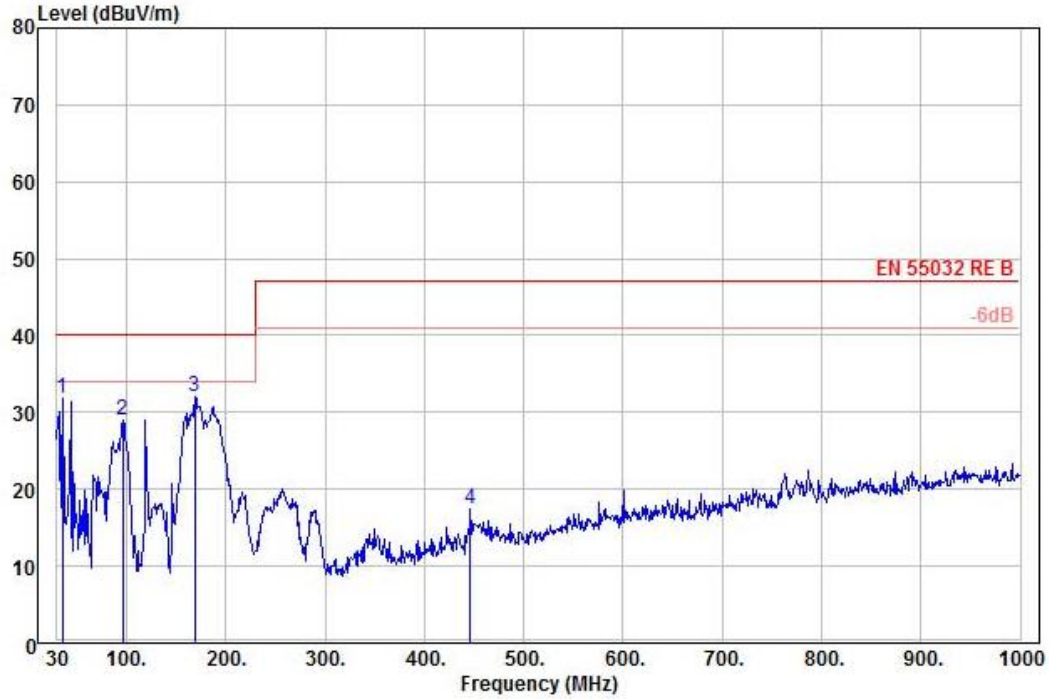
7.2.4. TEST RESULT

Product name	Solar charge controller	Antenna Distance	3 m
Model	DCK4860	Antenna Pole	Vertical / Horizontal
Test Mode	Working	Detector Function	Peak / Quasi-peak
Environmental Conditions	24.3℃, 54.2 % RH, 101.3 kPa	6 dB Bandwidth	120 kHz
Tested by	Brian	Test Result	Pass

Note:
Freq. = Emission frequency in MHz
Reading level (dB V) = Receiver reading(dB V)
Corr.Factor (dB/m)=Antenna factor(dB/m)+Cable loss(dB)-Preamp Factor(dB)
Measurement (dB V/m)=Reading level(dB V)+ Corr. Factor (dB/m)
Limit (dB V/m) = Limit stated in standard
Over Limit (dB) = Measurement (dB V/m) – Limit (dB V/m)
QP = Quasi-Peak
The highest frequency of the internal sources of the EUT was less than 108 MHz, so the measurement was only made up to 1 GHz.

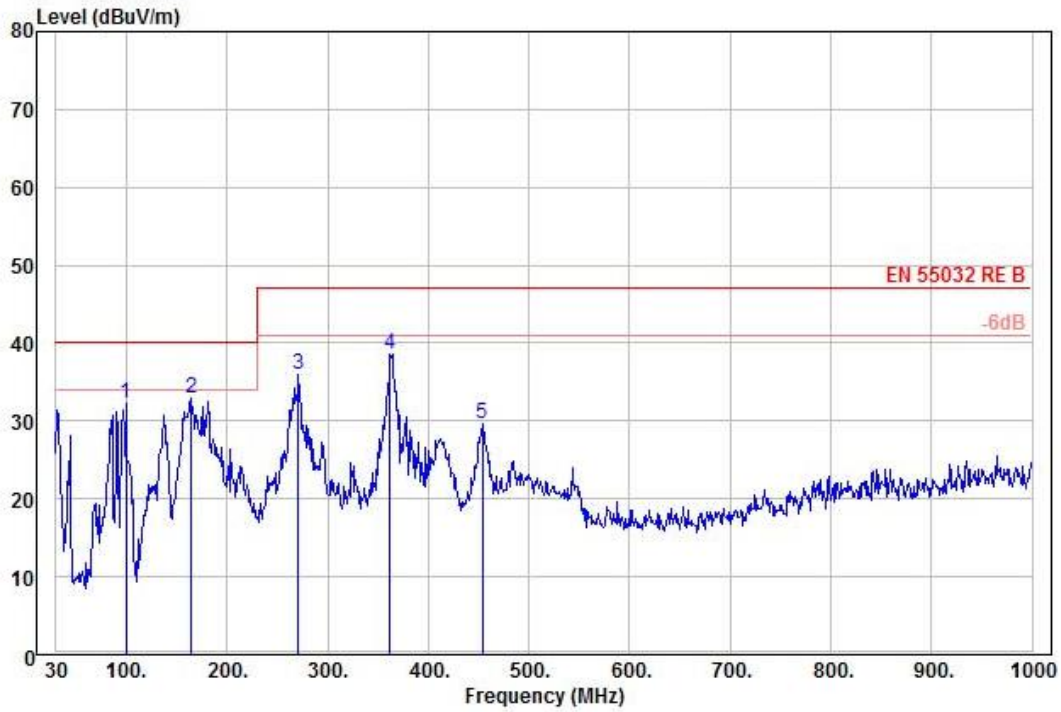
Please refer to the following diagram:

Vertical:



	Freq	Level	Read Level	Factor	Limit Line	Over Limit	Ant Factor	Cable Loss	Remark
	MHz	dBuV/m	dBuV	dB/m	dBuV/m	dB	dB/m	dB	
1	35.82	31.82	48.54	-16.72	40.00	-8.18	13.22	0.47	Peak
2	95.96	29.03	49.50	-20.47	40.00	-10.97	9.30	0.73	Peak
3	168.71	32.14	49.22	-17.08	40.00	-7.86	12.50	0.95	Peak
4	446.13	17.47	29.67	-12.20	47.00	-29.53	16.34	1.57	Peak

Horizontal:



	Freq	Level	Read Level	Factor	Limit Line	Over Limit	Ant Factor	Cable Loss	Remark
	MHz	dBuV/m	dBuV	dB/m	dBuV/m	dB	dB/m	dB	
1	99.84	32.20	52.61	-20.41	40.00	-7.80	9.35	0.74	Peak
2	164.83	32.92	49.19	-16.27	40.00	-7.08	13.33	0.94	Peak
3	270.56	35.89	52.92	-17.03	47.00	-11.11	12.06	1.21	Peak
4	361.74	38.63	53.39	-14.76	47.00	-8.37	14.08	1.40	Peak
5	453.89	29.61	41.24	-11.63	47.00	-17.39	16.88	1.58	Peak

7.3. HARMONICS CURRENT MEASUREMENT

7.3.1. LIMITS OF HARMONICS CURR MEASUREMENT

Limit for Class A equipment	
Harmonics Order N	Max. permissible harmonics current A
Odd harmonics	
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
15≦n≦39	0.15x(15/n)
Even harmonics	
2	1.08
4	0.43
6	0.30
8≦n≦40	0.23x8/n

Limit for Class D equipment		
Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
Odd Harmonics only		
3	3.4	2.30
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
13	0.30	0.21
15≦n≦39 (odd harmonics only)	3.85/n	0.15x(15/n)

Limit for Class C equipment	
Harmonics Order n	Max. permissible harmonics current expressed as a percentage of the input current at the fundamental frequency A
2	2
3	30xF
5	10
7	7
9	5
11≦n<≦39 (odd harmonics only)	3
F is the circuit power factor	

Note: Class A, B, C and D are classified according to item 7.3.2.of this report

7.3.2. TEST PROCEDURES

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the

maximum harmonic. The classification of EUT is according to section 5 of EN 61000-3-2.

The EUT is classified as follows:

Class A:

Balanced three-phase equipment, Household appliances excluding equipment as Class D, Tools excluding portable tools, Dimmers for incandescent lamps, audio equipment, equipment not specified in one of the three other classes.

Class B:

Portable tools; Arc welding equipment which is not professional equipment.

Class C:

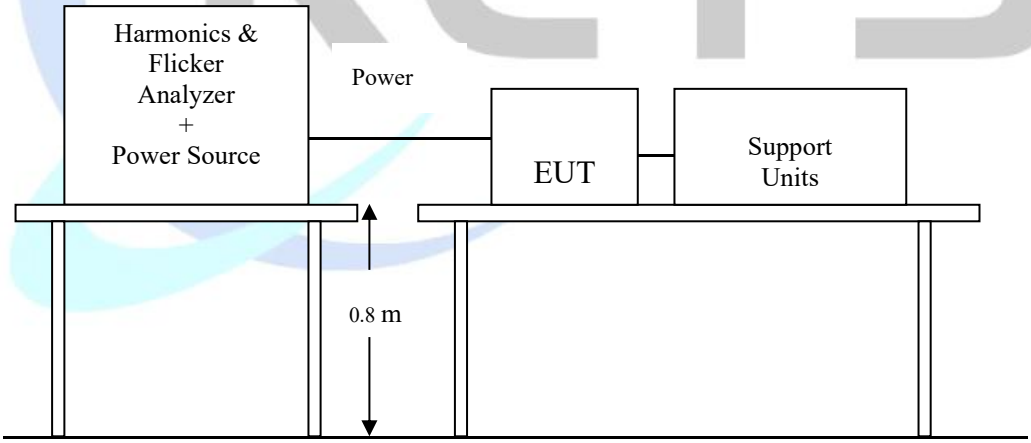
Lighting equipment

Class D:

Equipment having a specified power less than or equal to 600 W of the following types: Personal computers and personal computer monitors and television receivers.

The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

7.3.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.3.4. TEST RESULT

N/A

7.4. VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

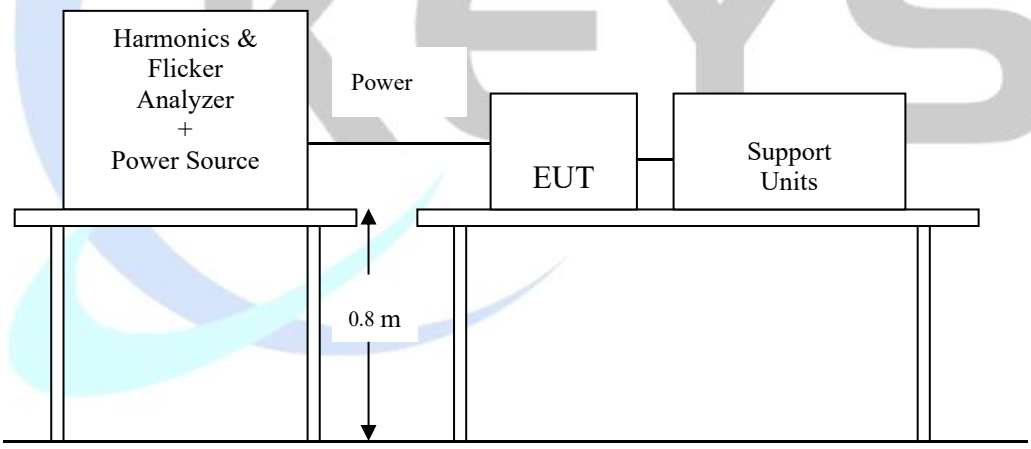
7.4.1. LIMITS OF VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

TEST ITEM	LIMIT	REMARK
P_{st}	1.0	P_{st} means short-term flicker indicator.
P_{lt}	0.65	P_{lt} means long-term flicker indicator.
T_{dt} (ms)	500	T_{dt} means maximum time that dt exceeds 3 %.
d_{max} (%)	4/6/7 %	d_{max} means maximum relative voltage change.
dc (%)	3.3 %	dc means relative steady-state voltage change

7.4.2. TEST PROCEDURE

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under full load operating conditions.
During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

7.4.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.4.4. TEST RESULT

N/A

8. IMMUNITY TEST

8.1. GENERAL DESCRIPTION

Product Standard	EN 55032	
	Test Type	**Minimum Requirement**
Basic Standard, Specification, and Performance Criterion required	EN 61000-4-2	Electrostatic Discharge – ESD: 8 kV air discharge, 4 kV Contact discharge, Performance Criterion B
	EN 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80 MHz to 1 GHz, 3 V/m, 80 % AM(1 kHz), Performance Criterion A
	EN 61000-4-4	Electrical Fast Transient/Burst - EFT, Power line: 1 kV, Signal line: 0.5 kV, Performance Criterion B
	EN 61000-4-5	Surge Immunity Test: 1.2/50 s Open Circuit Voltage, 8 /20 s Short Circuit Current, Power Port ~ Line to line: 1 kV, Line to ground: 2 kV Signal Port : 0.5 kV Performance Criterion B
	EN 61000-4-6	Conducted Radio Frequency Disturbances Test –CS: 0.15 ~ 80 MHz, 3 V r.m.s, 80 % AM, 1 kHz, Performance Criterion A
	EN 61000-4-8	Power frequency magnetic field immunity test 50 Hz, 1 A/m Performance Criterion A
	EN 61000-4-11	Voltage Dips: i) 0% reduction for 0.5 period, Performance Criterion B ii) 70% reduction for 25 periods, Performance Criterion C Voltage Interruptions: 0% reduction for 250 periods, Performance Criterion C

8.2. GENERAL PERFORMANCE CRITERIA DESCRIPTION

Criteria A:	During and after the test the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a minimum performance level specified by the manufacturer when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the EUT if used as intended.
Criteria B:	After the test, the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the EUT if used as intended.
Criteria C:	During and after testing, a temporary loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls or cycling of the power to the EUT by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

8.3. ELECTROSTATIC DISCHARGE (ESD)

8.3.1. TEST SPECIFICATION

Basic Standard:	EN 61000-4-2
Discharge Impedance:	330 Ω
Charging Capacity:	150 pF
Discharge Voltage:	Air Discharge: 8 kV (Direct) Contact Discharge: 4 kV (Direct/Indirect)
Polarity:	Positive & Negative
Number of Discharge:	10 (Air discharge for single polarity discharge) 25 (Contact discharge for single polarity discharge)
Discharge Mode:	1 time/s
Performance Criterion:	B

8.3.2. TEST PROCEDURE

The discharges shall be applied in two ways:

a) Contact discharges to the conductive surfaces and coupling planes:
50 dischargers (25 with positive and 25 with negative polarity) shall be applied on each accessible metallic part of the enclosure, terminals are excluded. In case of a non-conductive enclosure, dischargers shall be applied on the horizontal or vertical coupling planes. Test shall be performed at a maximum repetition rate of one discharge per second.

b) Air discharges at slots and apertures and insulating surfaces:
On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

The basic test procedure was in accordance with IEC 61000-4-2:

a) The EUT was located 0.1 m minimum from all side of the HCP (dimensions 1.6 m x 0.8 m).

b) The support units were located another table 30 cm away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10cm with EUT.

c) The time interval between two successive single discharges was at least 1 second.

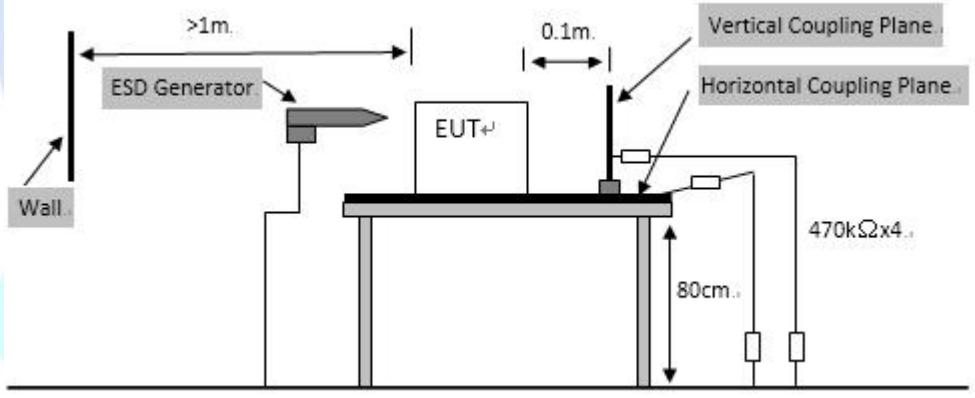
d) Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.

e) Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.

f) At least ten single discharges (in the most sensitive polarity) were applied at the front edge of each HCP opposite the center point of each unit of the EUT and 0.1 meter from the front of the EUT. The long axis of the discharge electrode was in the plane of the HCP and perpendicular to its front edge during the discharge.

g) At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane (VCP) in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5 m x 0.5 m) was placed vertically to and 0.1 meter from the EUT.

8.3.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Note:

1) TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the ground reference plane (GRP) . The GRP consisted of a sheet of aluminum at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system. A horizontal coupling plane (HCP) (1.6 m x 0.8 m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of EN

61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5 mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

2) FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the ground reference plane by an insulating support of 0.1 meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

8.3.4. TEST RESULT

Product	Solar charge controller	Environmental Conditions	24.5℃, 54.3 % RH, 101.3 kPa
Model	DCK4860	Tested By	Brian
Test mode	Working	Test Result	Pass

Air Discharge					
Test Points	Test Levels	Results			
	8 kV	Pass	Fail	Observation	Performance Criterion
Slot 4 Points	☒	☒	☐	Note ☐1☒2☐3	B

Contact Discharge					
Test Points	Test Levels	Results			
	4 kV	Pass	Fail	Observation	Performance Criterion
HCP 4 Points	☒	☒	☐	Note ☐1☒2☐3	B
VCP 4 Points	☒	☒	☐	Note ☐1☒2☐3	B

Note: 1) There was no change compared with initial operation during the test.
2) During the test the luminous intensity change, and after the test the luminous intensity can be restored to its initial value within 1 min.
3) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.

8.4. RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD (RS)

8.4.1. TEST SPECIFICATION

Basic Standard:	EN 61000-4-3
Frequency Range:	80 MHz ~ 1000 MHz
Field Strength:	3 V/m
Modulation:	1 kHz Sine Wave, 80 %, AM Modulation
Frequency Step:	1 % of preceding frequency value
Polarity of Antenna:	Horizontal and Vertical
Test Distance:	3 m
Antenna Height:	1.5 m
Performance Criterion:	A

8.4.2. TEST PROCEDURE

The test procedure was in accordance with EN 61000-4-3

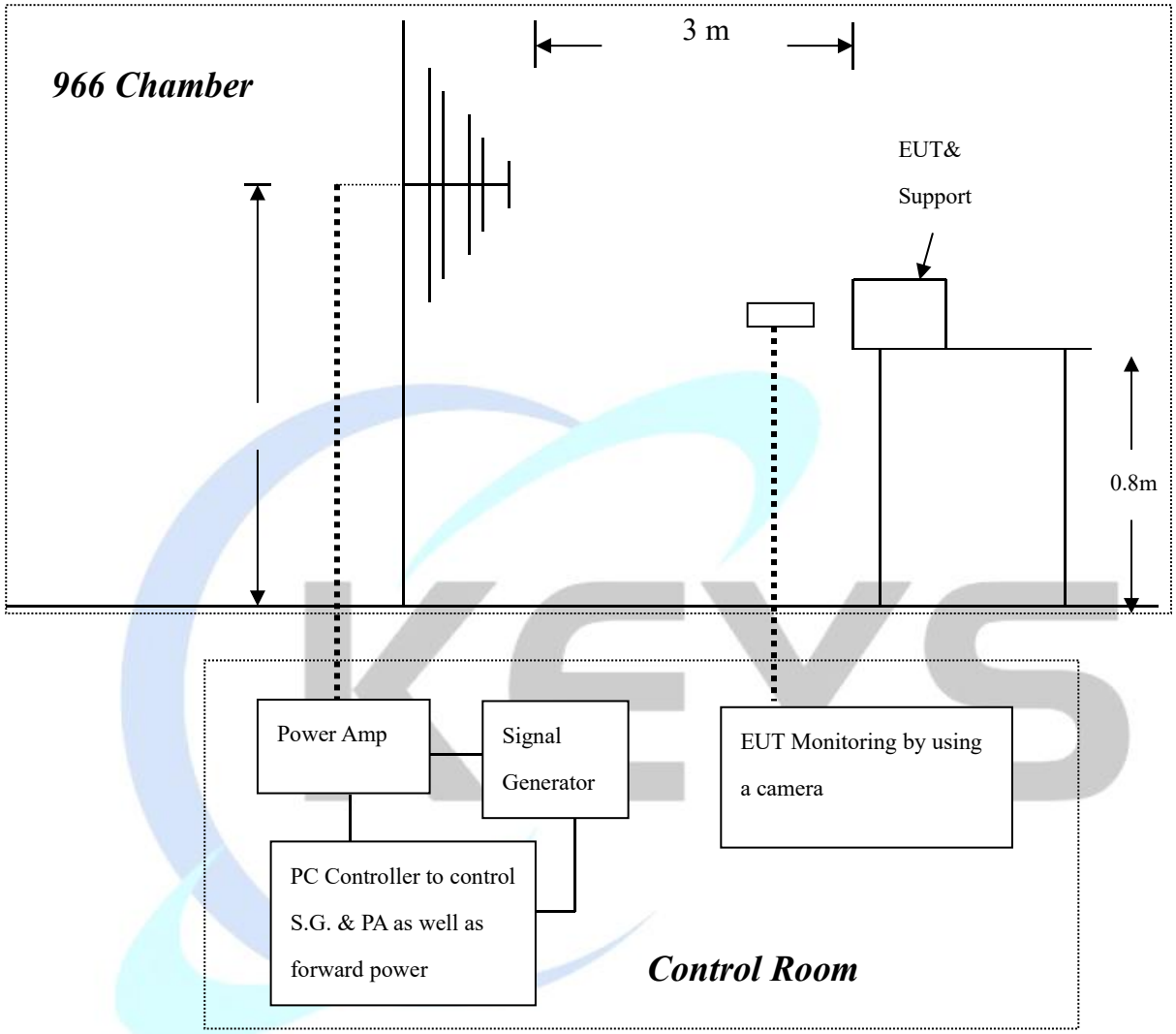
a) The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.

b) The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1 kHz sine-wave. The rate of sweep did not exceed 1.5 x 10^{-3} decade/s, where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value.

c) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.

d) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

8.4.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Note:

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

8.4.4. TEST RESULT

Product	Solar charge controller	Environmental Conditions	24.5℃, 54.3 % RH, 101.1 kPa
Model	DCK4860	Tested By	Brian
Test mode	Working	Test Result	Pass

Frequency (MHz)	Polarity	Position	Field Strength (V/m)	Observation	Performance Criterion
80 ~ 1000	V&H	Front	3	Note ☒1 ☐2 ☐3	A
80 ~ 1000	V&H	Rear	3	Note ☒1 ☐2 ☐3	A
80 ~ 1000	V&H	Left	3	Note ☒1 ☐2 ☐3	A
80 ~ 1000	V&H	Right	3	Note ☒1 ☐2 ☐3	A

Note: 1) There was no change compared with initial operation during the test.
2) During the test the luminous intensity change ,and after the test the luminous intensity can be restored to its initial value within 1 min.
3) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.

8.5. ELECTRICAL FAST TRANSIENT (EFT)

8.5.1. TEST SPECIFICATION

Basic Standard:	EN 61000-4-4
Test Voltage:	Power Line: 1 kV
	Signal/Control Line: 0.5 kV
Polarity:	Positive & Negative
Impulse Frequency:	5 kHz
Impulse Wave-shape:	5/50 ns
Burst Duration:	15 ms
Burst Period:	300 ms
Test Duration:	2 mins
Performance Criterion:	B

8.5.2. TEST PROCEDURE

EUT is placed on a 0.1 m tall wooden table.

EUT operate at normal mode, the transient/burst was 5/50 ns in accordance with EN 61000-4-4, both positive and negative polarity burst waveform were applied.

The duration time of each test line was 2 minutes.

8.5.3. TEST SETUP

The EUT installed in a representative system as described in section 7 of EN 61000-4-4.

For the actual test configuration, please refer to the related item – photographs of the test configuration.

8.5.4. TEST RESULT

N/A

8.6. SURGE IMMUNITY TEST

8.6.1. TEST SPECIFICATION

Basic Standard:	EN 61000-4-5
Wave-Shape:	Combination Wave 1.2/50 s Open Circuit Voltage 8/20 s Short Circuit Current
Test Voltage:	Power Port ~ Line to line: 1 kV, Line to ground: 2 kV
Surge Input/Output:	Power Line: L-N / L-PE / N-PE
Generator Source Impedance:	2 Ω between networks 12 Ω between network and ground
Polarity:	Positive/Negative
Phase Angle:	0° /90° /180° /270°
Pulse Repetition Rate:	1 time / min
Number of Tests:	5 positive polarity pulses, and 5 negative polarity pulses
Performance Criterion:	B

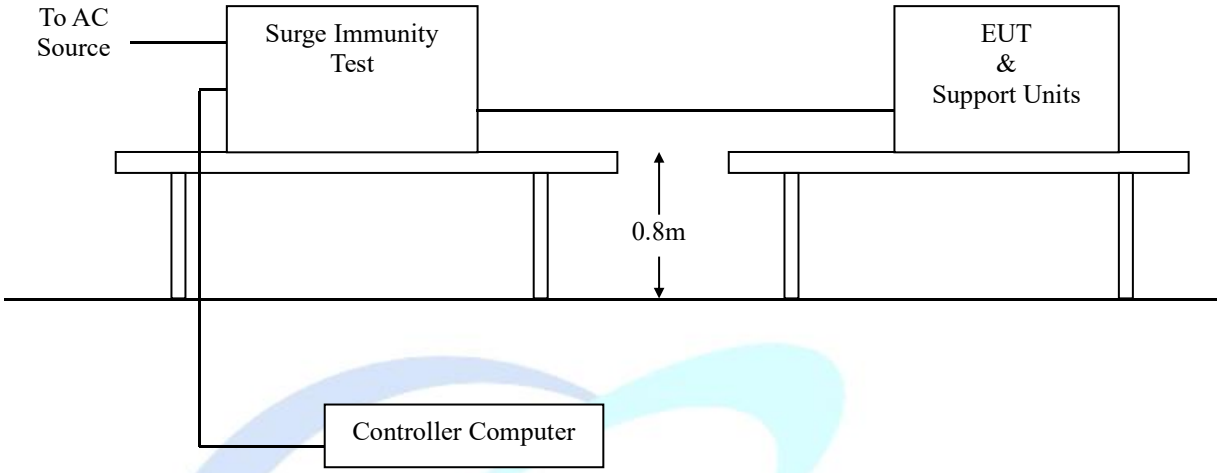
8.6.2. TEST PROCEDURE

EUT is placed on a 0.1 m (table type equipment) / 0.8 m (floor type equipment) tall wooden table.

EUT operate at normal mode, two types of combination wave generator (1.2/50 us open-circuit voltage and 8/20 us short-circuit current) are applied to the EUT power supply terminals via the capacitive coupling network.

The power cord between the EUT and the coupling/decoupling network shall not exceed 2 m in length.

8.6.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

8.6.4. TEST RESULT

N/A

8.7. CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

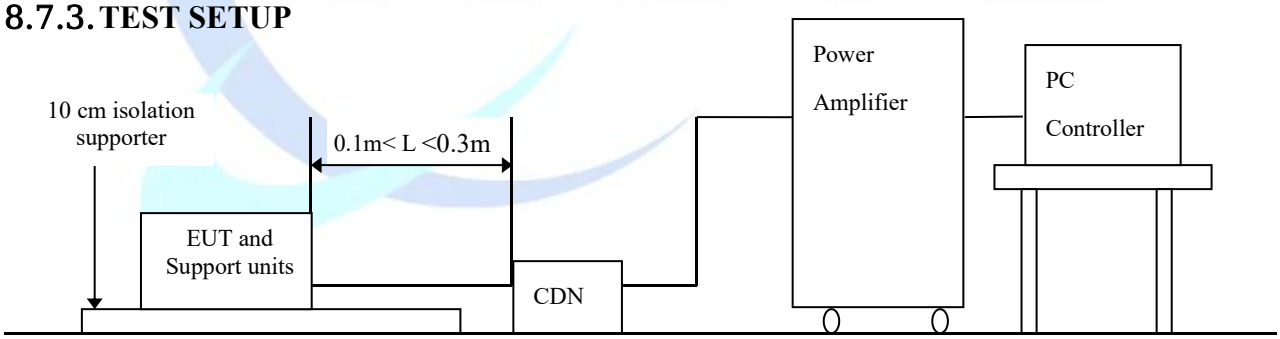
8.7.1. TEST SPECIFICATION

Basic Standard:	EN 61000-4-6
Frequency Range:	0.15 MHz ~80 MHz
Field Strength:	3 V
Modulation:	1 kHz Sine Wave, 80 %, AM Modulation
Frequency Step:	1 % of preceding frequency value
Coupled cable:	Power Mains, Shielded
Coupling device:	CDN-M3/2 (3 wires/2 wires)
Performance Criterion:	A

8.7.2. TEST PROCEDURE

The EUT shall be tested within its intended operating and climatic conditions.
The test shall performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50 Ω load resistor.
The frequency range was swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal was modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate was 1.5 x 10^{-3} decades/s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value the dwell time of the amplitude modulated carrier at each frequency was 0.5 s.

8.7.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration

Note: 1) The EUT is setup 0.1 m above Ground Reference Plane

2) All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

8.7.4. TEST RESULT

N/A

8.8. POWER FREQUENCY MAGNETIC FIELD

8.8.1. TEST SPECIFICATION

Basic Standard:	EN 61000-4-8
Frequency Range:	50 Hz
Field Strength:	1 A/m
Observation Time:	5 minutes
Inductance Coil:	Rectangular type, 1 m x 1 m
Performance Criterion:	A

8.8.2. TEST PROCEDURE

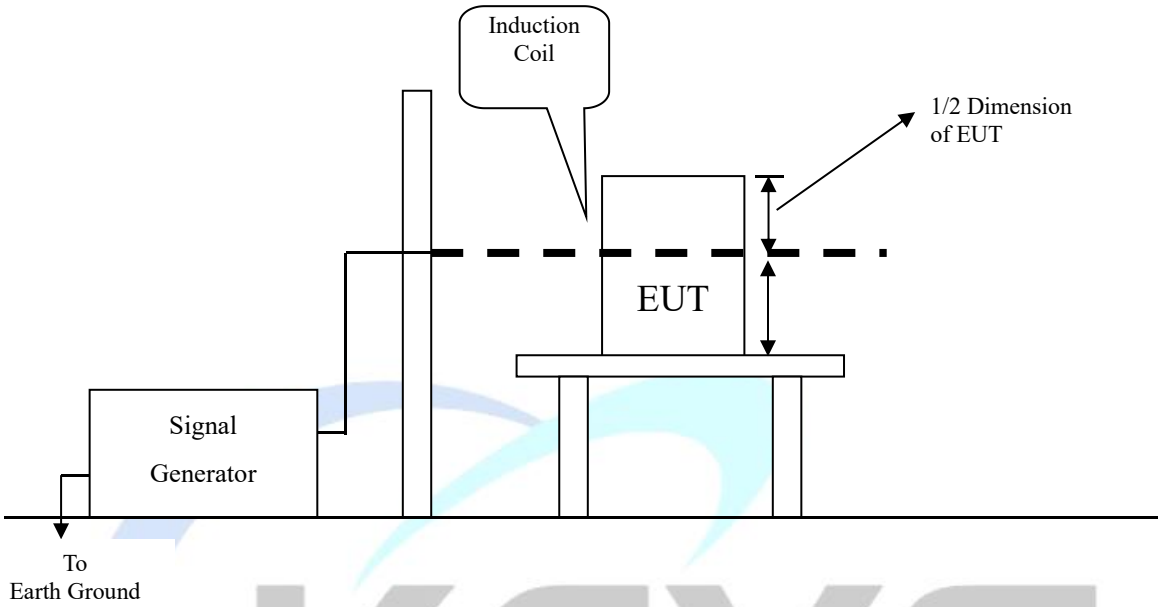
The equipment is configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0.1 m-thick insulating support.

The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.

The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.

The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

8.8.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration
Note:

TABLETOP EQUIPMENT
The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

FLOOR-STANDING EQUIPMENT
The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

8.8.4. TEST RESULT

N/A

8.9. VOLTAGE DIP & VOLTAGE INTERRUPTIONS

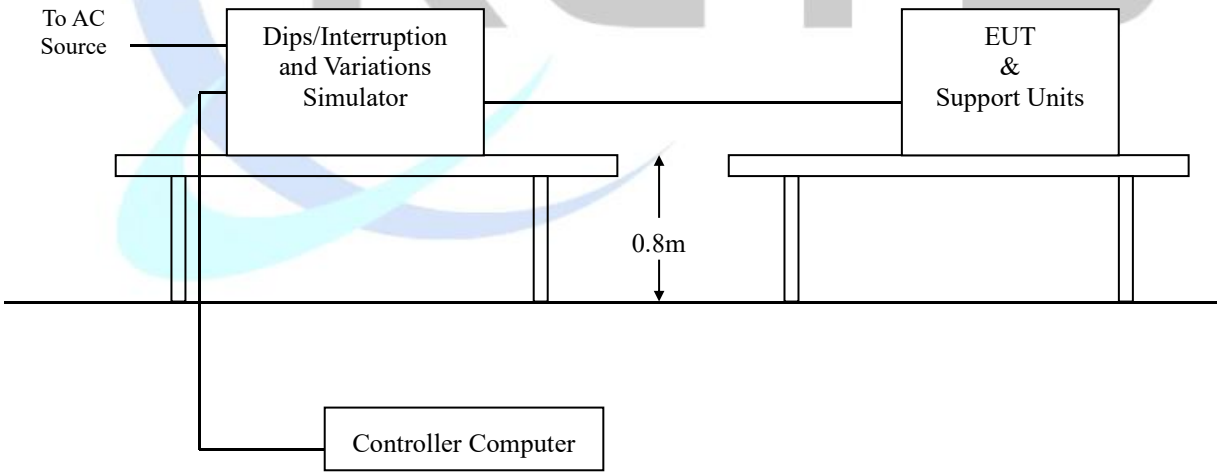
8.9.1. TEST SPECIFICATION

Basic Standard:	EN 61000-4-11
Test Duration Time:	3 test events in sequence
Interval Between Event:	10 seconds
Phase Angle:	0°
Test Cycle:	3 times
Performance Criterion:	0% U_T / 0.5 P, Criterion: B
	70% U_T / 25 P, Criterion: C
	0% U_T / 250 P, Criterion: C

8.9.2. TEST PROCEDURE

The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
Setting the parameter of tests and then perform the test software of test simulator.
Changes to the voltage level shall occur at 0 degree crossing point in the a.c. voltage waveform.
Record the test result in test record form.

8.9.3. TEST SETUP



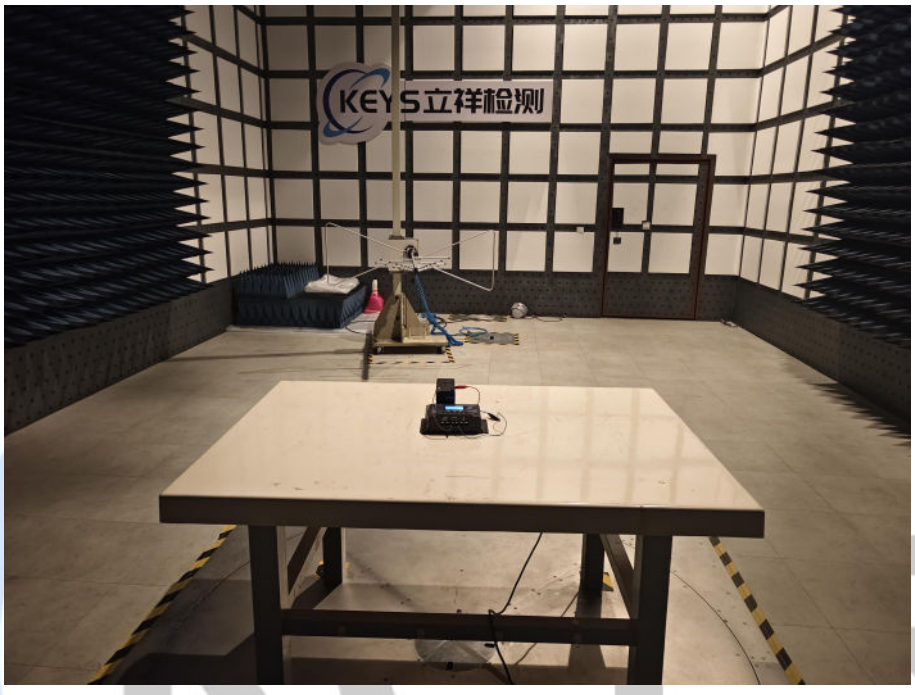
For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

8.9.4. TEST RESULT

N/A

9. PHOTOGRAPHS OF THE TEST CONFIGURATION

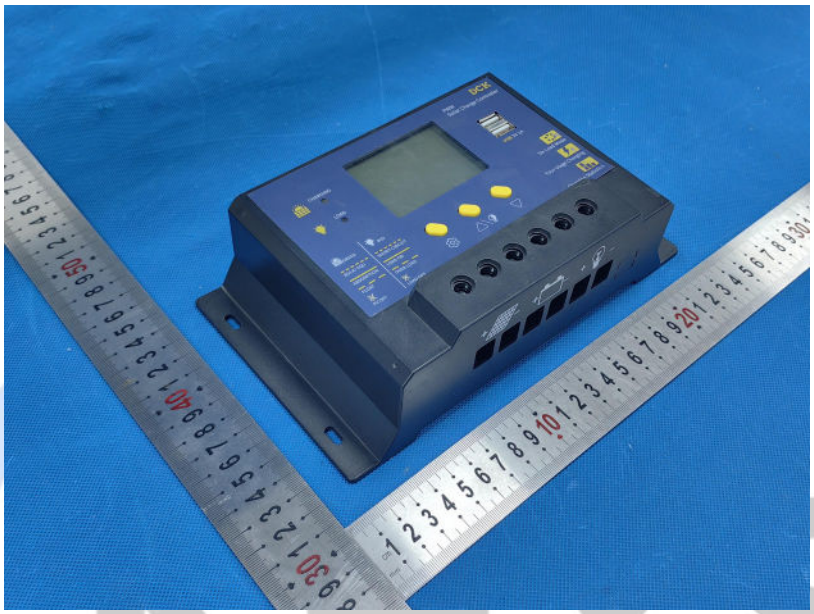
RADIATED EMISSION TEST

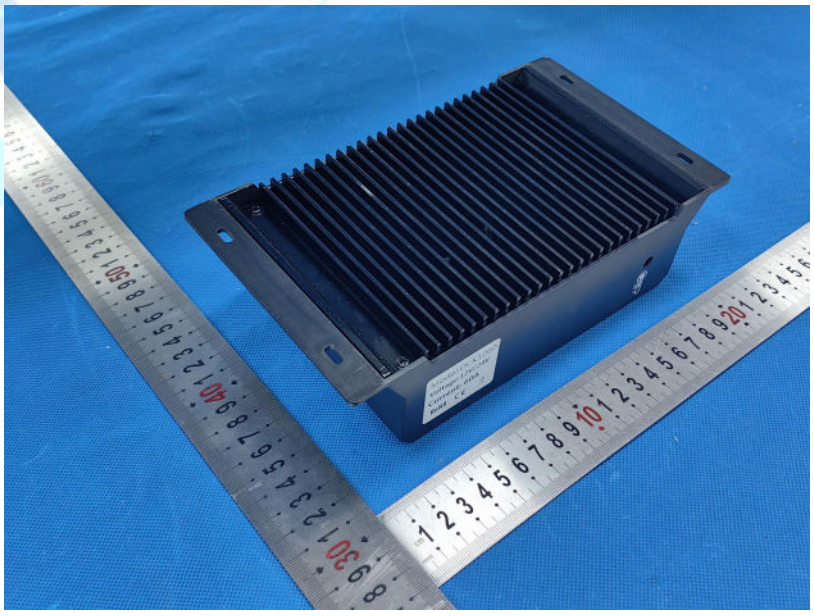


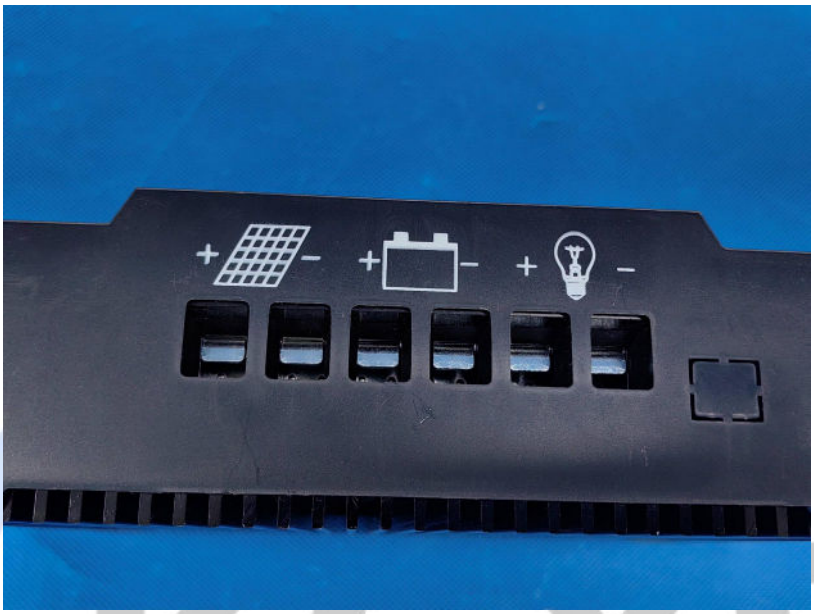
ESD TEST

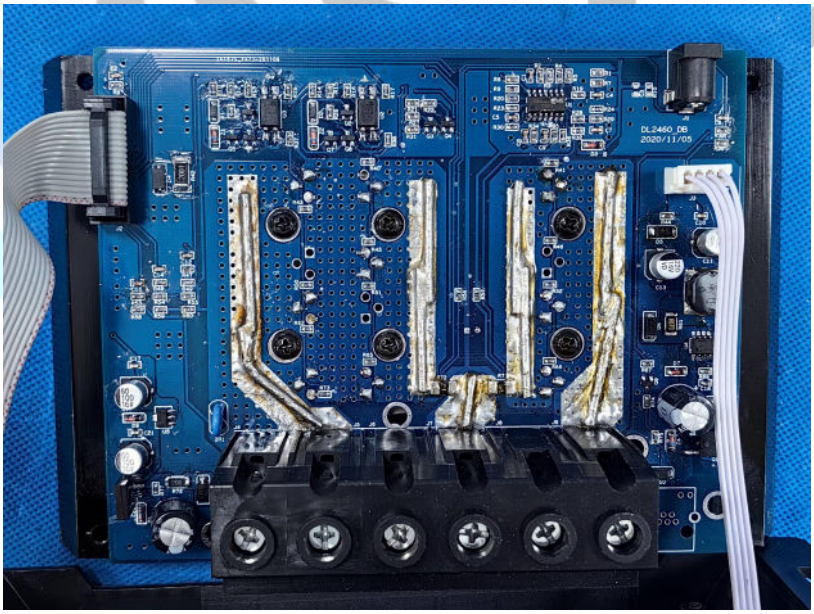


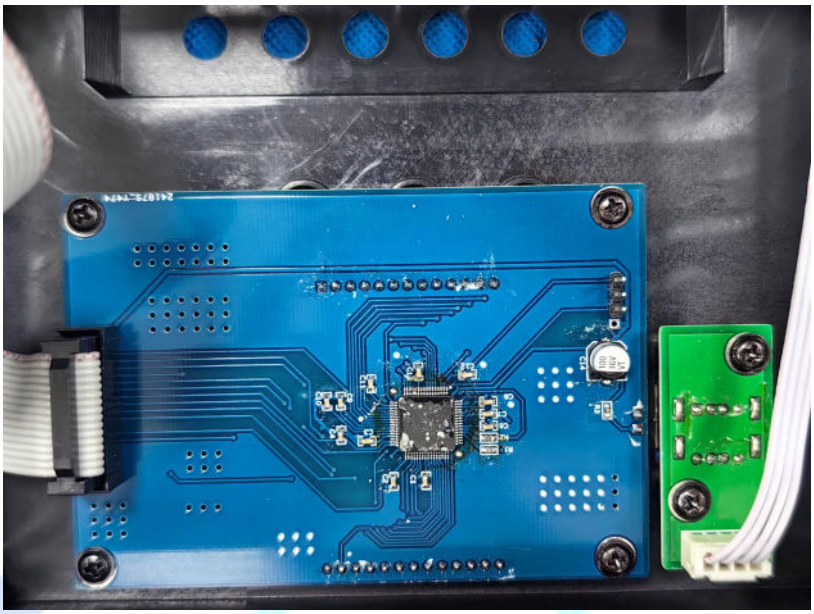
10. PHOTOGRAPHS OF EUT











— End of report —